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| SEARCHED | | | |
|---------------|------|---------|-------|
| Class | Sub. | Date | Exmr. |
| 382 | 100 | 8/26/04 | AW |
| | 232 | 8/26/04 | AW |
| 358 | 3.28 | 8/26/04 | AW |
| | 3.29 | 8/26/04 | AW |
| | 3.31 | 8/26/04 | AW |
| 380 | 252 | 8/26/04 | AW |
| | 51 | 8/26/04 | AW |
| | 54 | 8/26/04 | AW |
| 713 | 176 | 8/26/04 | AW |
| 340 | 5.8 | 8/27/04 | AW |
| | 5.86 | 8/27/04 | AW |
| 283 | 72 | 8/27/04 | AW |
| | 74 | 8/27/04 | AW |
| | 79 | 8/27/04 | AW |
| | 85 | 8/27/04 | AW |
| | 901 | 8/27/04 | AW |
| update search | | 5/2/05 | AW |

| INTERFERENCE SEARCHED | | | |
|-----------------------|------|--------|-------|
| Class | Sub. | Date | Exmr. |
| 382 | 100 | 5/2/05 | AW |
| 358 | 3.28 | 5/2/05 | AW |
| 340 | 5.86 | 5/2/05 | AW |

| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | |
|---|---------|-------|
| Searched Examiner's | Date | Exmr. |
| personal collection of Steganography/Digital Watermarking Refs., Including NPL (compiled from searches of IEEE, ACM, SPIE, IETICE, Springer databases and internet searches), FOR. PAT. DOCS. (compiled from searches in EPO, JPO, DERWENT files in EAST and internet searches of EPO, JPO, Canada Pat. Off. websites), and US PAT. DOCS. (compiled from searches in USPAT and PG-PUB files in EAST). | 8/26/04 | AW |
| | 8/26/04 | AAF |
| | 8/26/04 | AW |

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